Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/660,726	HAN, IN HEE
Examiner	Art Unit

3749

Jiping Lu

SEARCHED					
Class	Subclass	Date	Examiner		
34	130,132 595,604 606,607 138,139	9/29/2005	JL		
285	330,913	9/29/2005	JL		
	914				
138	114,155	9/29/2005	JL		
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ABOVE	UPDATED	5/23/2006	JL		
126	307R,312	5/23/2006	JL		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
CONSULTED EXAMINER ERIC K. NICHOLSON FOR SEARCH IN CLASS 285	9/29/2005	JL
CONSULTED EXAMINER PATRICK F BRINSON FOR SEARCH IN CLASS 138	9/29/2005	· JL
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